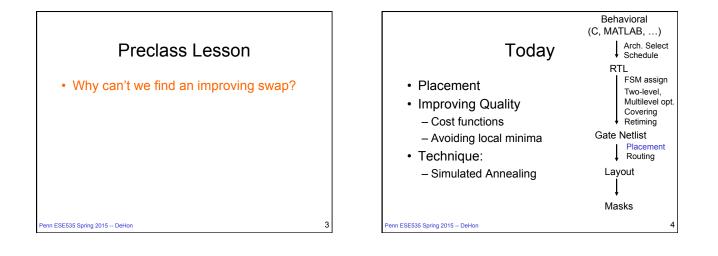
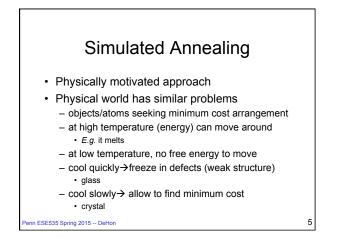
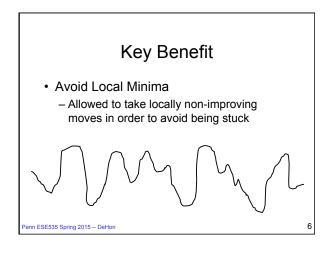
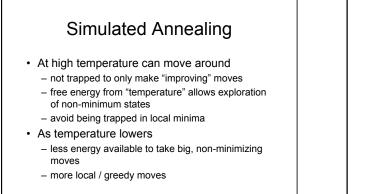
#### ESE535: Preclass **Electronic Design Automation** • Squared wirelength for top placement? Squared wirelength for bottom placement? Day 12: March 2, 2015 • Number of swaps? Placement II Squared wirelength after swap for each (Simulated Annealing) of these cases? - Sample from class - (everyone assigned 1 or 2) enn enn ESE535 Spring 2015 – DeHon Penn ESE535 Spring 2015 -- DeHon









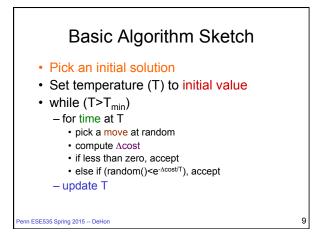
#### enn ESE535 Spring 2015 -- DeHon

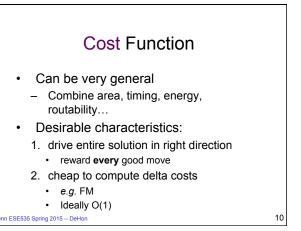
# **Design Optimization**

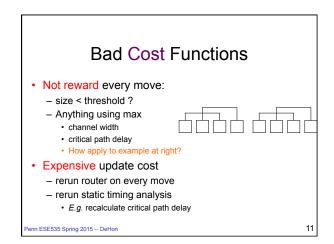
#### Components:

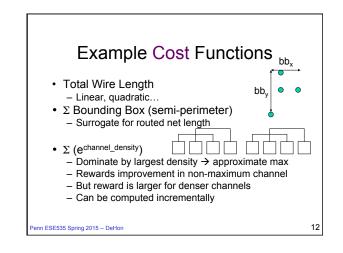
- 1. "Energy" (Cost) function to minimize
  - represent entire state, drives system forward
- 2. Moves
  - local rearrangement/transformation of solution
- 3. Cooling schedule
  - initial temperature
  - temperature steps (sequence)
  - time at each temperature

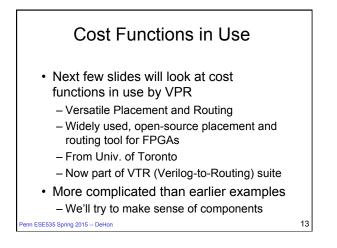
enn ESE535 Spring 2015 -- DeHon

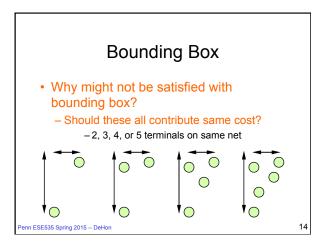


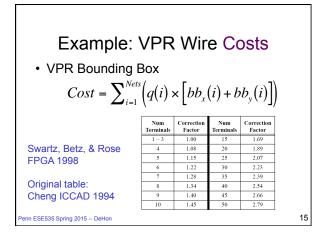












## Example: VPR Timing Costs

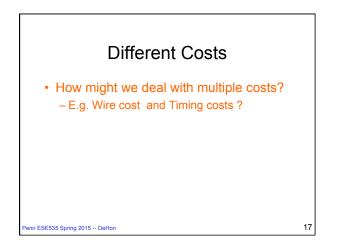
- Criticality(e)=1-Slack(e)/Dmax
- TCost(e)=Delay(e)\*Criticality(e)<sup>CriticalityExp</sup>
- · Keep all edge Criticalities in a table
- Recompute Net Criticality
  at each Temperature

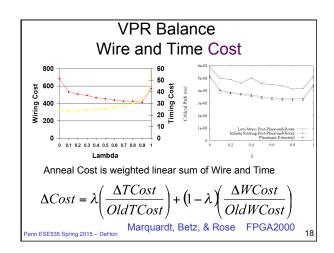
Marquardt, Betz, & Rose

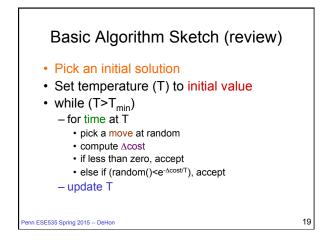
FPGA2000

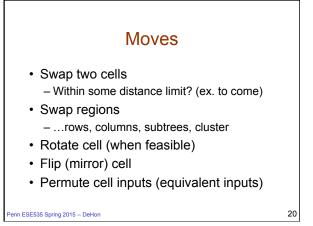
in ESE535 Spring 2015 – DeHon

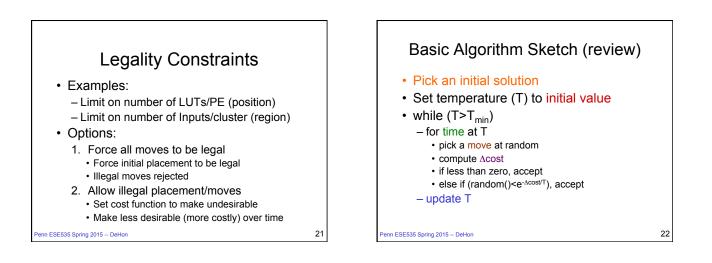
y	Criticality Exponent	Placement Estimated Critical Path (ns) (20 Circuit Geometric Average)	Wiring Cost (20 Circuit Geometric Average)
	1	38.9	342.0
	2	37.1	343.4
	3	35.9	344.0
	4	34.8	344.7
	5	34.7	343.7
	6	34.8	341.6
	7	34.3	339.6
	8	34.3	340.1
	9	33.8	339.6
	10	34.3	337.9
	11	34.3	336.3

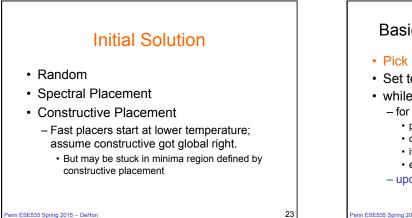


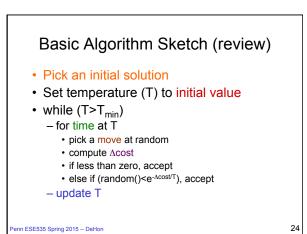


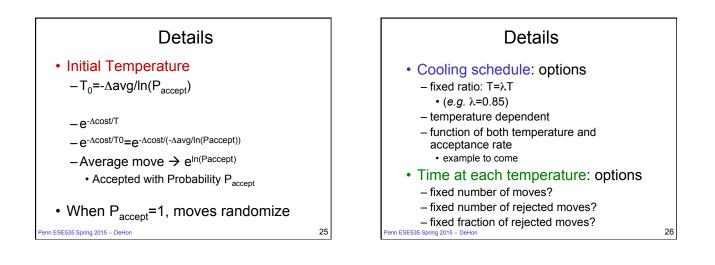


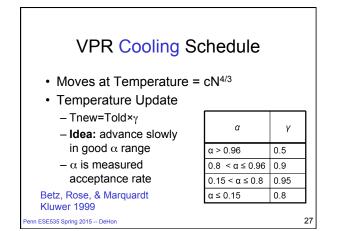


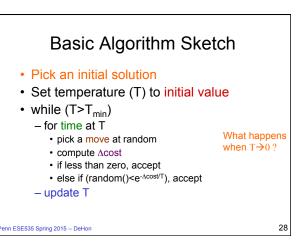


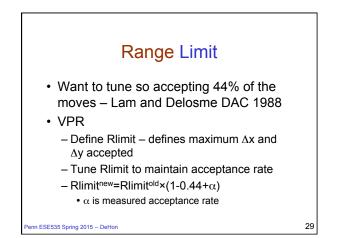


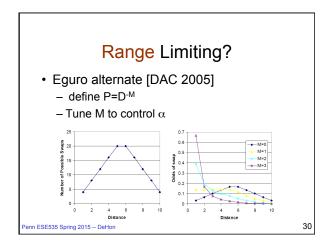


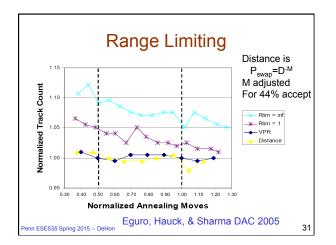


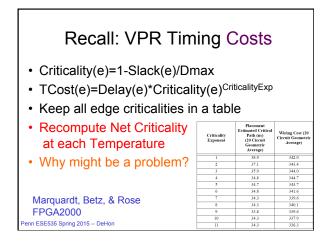


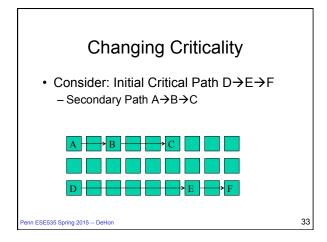


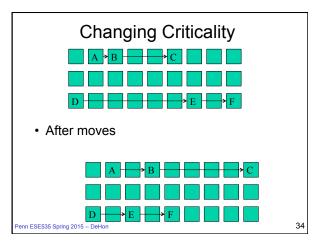


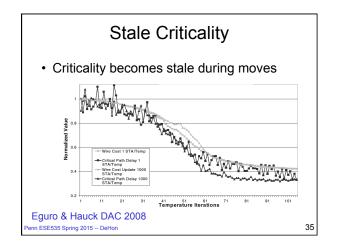


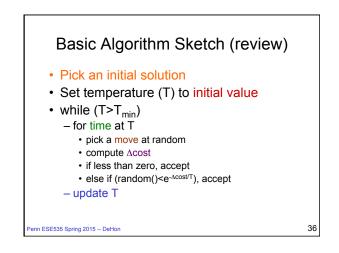












## Variant: "Rejectionless"

- · Order moves by cost compare FM
- Pick random number first
- · Use random to define range of move costs will currently accept
- · Pick randomly within this range
- · Idea: never pick a costly move which will be rejected

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### Simulated Annealing Theory

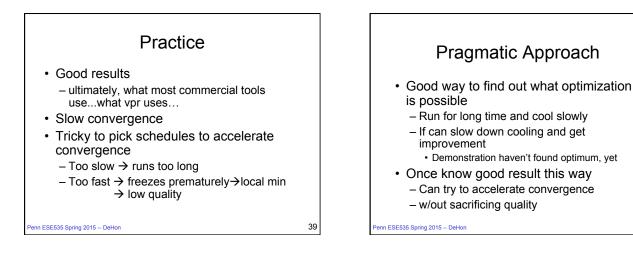
- If stay long enough at each cooling stage
  - will achieve tight error bound
- If cool long enough - will find optimum
- ...but is it any less work than exhaustive exploration?

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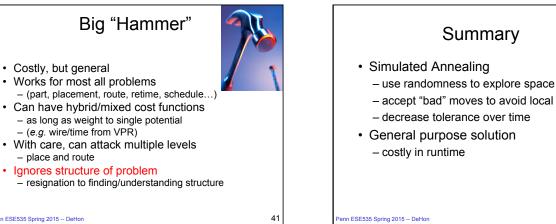
40

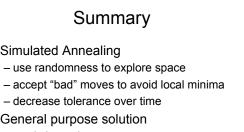
- Good to have a continuum....

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· Costly, but general

- place and route

- (e.g. wire/time from VPR)

# Big Ideas:

- Use randomness to explore large (non-convex) space
  - Sample various parts of space
  - Avoid becoming trapped in local minimum
- Technique
  - Simulated Annealing

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# Admin • Reading for Wednesday online • Assignment 6 due Thursday